

Search Notes

Application/Control No.

10/830,008

Examiner

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Applicant(s)/Patent under
Reexamination

TAKAHASHI, KEI

Art Unit

2839

SEARCHED

Class	Subclass	Date	Examiner
439	327	6/5/2005	KN
↓	347	↓	↓
↓	638	↓	↓
↓	945	↓	↓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR